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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO
09/971,953	10/05/2001	Paul S. Andry	JP9-2000-0187US1 (8728-42	4099
7:	590 12/31/2003		EXAM	INER
Frank Chau			MALDONADO, JULIO J	
F. CHAU & ASSOCIATES, LLP Suite 501			ART UNIT	PAPER NUMBER
1900 Hempstead Turnpike			2823	
East Meadow, NY 11554			DATE MAILED: 12/31/2003	

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)
Office Action Summary	09/971,953	ANDRY ET AL.
omoo nodon odininary	Examiner	Art Unit
The MAILING DATE of this communication a	Julio J. Maldonado  ppears on the cover sheet with	2823 the correspondence address
Period for Reply	ppour our mo our or one or man	and some spendeness and see
A SHORTENED STATUTORY PERIOD FOR REP THE MAILING DATE OF THIS COMMUNICATION  - Extensions of time may be available under the provisions of 37 CFR 1 after SIX (6) MONTHS from the mailing date of this communication.  - If the period for reply specified above is less than thirty (30) days, a re  - If NO period for reply is specified above, the maximum statutory periol  - Failure to reply within the set or extended period for reply will, by statu  - Any reply received by the Office later than three months after the maili earned patent term adjustment. See 37 CFR 1.704(b).  Status	.136(a). In no event, however, may a repl eply within the statutory minimum of thirty (3 d will apply and will expire SIX (6) MONTH ate, cause the application to become ABAN	y be timely filed  30) days will be considered timely. IS from the mailing date of this communication.  IDONED (35 U.S.C. § 133).
1) Responsive to communication(s) filed on 29	September 2003.	
2a)⊠ This action is <b>FINAL</b> . 2b)□ Thi	s action is non-final.	
3) Since this application is in condition for allow closed in accordance with the practice under		
Disposition of Claims		
4)⊠ Claim(s) <u>1-13,15-17 and 22</u> is/are pending in	the application.	
4a) Of the above claim(s) is/are withdr	awn from consideration.	
5) Claim(s) is/are allowed.		
6) Claim(s) <u>1-13,15-17 and 22</u> is/are rejected.		
7) Claim(s) is/are objected to.		
8) Claim(s) are subject to restriction and	or election requirement.	
Application Papers		
9) The specification is objected to by the Examir		the Eveniner
10) The drawing(s) filed on is/are: a) ac		
Applicant may not request that any objection to th Replacement drawing sheet(s) including the corre	• • • • • • • • • • • • • • • • • • • •	
11) The oath or declaration is objected to by the B		-
Priority under 35 U.S.C. §§ 119 and 120	Examinor. Note the attached to	
12) Acknowledgment is made of a claim for foreign	an priority under 35 U.S.C. & 1	119(a)-(d) or (f).
a) All b) Some * c) None of:  1. Certified copies of the priority documer  2. Certified copies of the priority documer  3. Copies of the certified copies of the priority documer  application from the International Bure  * See the attached detailed Office action for a list  13) Acknowledgment is made of a claim for domest since a specific reference was included in the fraction of the foreign language p  14) Acknowledgment is made of a claim for domest reference was included in the first sentence of	nts have been received.  Ints have been received in Application of the certified copies not restic priority under 35 U.S.C. §  First sentence of the specification of the certified copies not restic priority under 35 U.S.C. §  First sentence of the specification	polication No eceived in this National Stage eceived. 119(e) (to a provisional application) ion or in an Application Data Sheet. en received. § 120 and/or 121 since a specific
Attachment(s)		
Notice of References Cited (PTO-892)     Notice of Draftsperson's Patent Drawing Review (PTO-948)     Information Disclosure Statement(s) (PTO-1449) Paper No(s)	5) D Notice of Info	mmary (PTO-413) Paper No(s) wrmal Patent Application (PTO-152)

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### **DETAILED ACTION**

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## Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 1, 2, 4-7, 9-17 and 22 are rejected under 35 U.S.C. 103(a) as being unpatentable over Calvert et al. (U.S. 6,348,240 B1) in view of the applicants' admitted prior art.

In reference to claims 1, 2, 4, 6, 9-17 and 22, Calvert et al. (Fig.1) in a related method to selectively deposit a conductive layer teach providing a substrate (column 7, lines 17 - 20); forming a first insulation layer on a substrate, wherein said layer is a diamond layer (column 7, lines 17 - 20); forming a second insulation layer on the first insulation layer, the second insulation layer having predetermined functional groups comprising OH functional groups (column 5, lines 15 - 34); etching the second insulation layer in accordance with the patterns of a patterned mask to create a patterned insulation layer (column 6, lines 5 - 22); treating the patterned insulation layer with a silane coupling agent reacting with the predetermined functional groups (column 5, lines 42 - 65); treating the patterned insulation layer with a catalyst-containing solution, wherein said catalyst containing solution includes palladium dichloride (column 6, lines 23 - 34); and depositing electrically conductive material on the patterned

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insulation layer (column 5, line 15 – column 7, line 40), wherein the electrically conductive material comprises gold (Au) (column 2, lines 16 – 19).

Calvert et al. fail to teach forming a patterned polymer layer by photolithography having patterns on the second insulation layer; and striping the patterned polymer layer to expose the patterned insulation layer. However, the admitted prior art (Figs.1a-h) teaches the steps of providing a substrate (103); forming an insulation layer (101) on the substrate (103); forming a patterned polymer layer (109) by photolithography having the patterns on the insulation layer (101); etching the insulation layer (101) in accordance with the patterns of the patterned polymer layer (109) to create a patterned insulation layer; and stripping the patterned polymer layer (109) to expose the patterned insulation layer (page 1, line 10 – page 3, line 8). Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to use the patterned polymer layer as taught in the prior art to pattern the second insulation layer in the selective deposition process of Calvert et al., since this process involves conventional processes in the formation of patterns using photolithography (page 1, lines 16 – 17).

In reference to claims 5 and 7, the combined teachings of Calvert et al. and the prior art substantially teach all aspects of the invention but fail to teach the second insulation layer having a thickness between about 1 nm and about 10 nm; and the patterned polymer layer having a thickness between about 50 nm and 100 nm.

Notwithstanding, it would have been an obvious matter of design choice bounded by well known manufacturing constraints and ascertainable by routine experimentation and

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optimization to choose these particular dimensions because applicant has not disclosed that the dimensions are for a particular unobvious purpose, produce an unexpected result, or are otherwise critical, and it appears prima facie that the process would possess utility using another dimension. Indeed, it has been held that mere dimensional limitations are prima facie obvious absent a disclosure that the limitations are for a particular unobvious purpose, produce an unexpected result, or are otherwise critical. See, for example, In re Rose, 220 F.2d 459, 105 USPQ 237 (CCPA 1955); In re Rinehart, 531 F.2d 1048, 189 USPQ 143 (CCPA 1976); Gardner v. TEC Systems, Inc., 725 F.2d 1338, 220 USPQ 777 (Fed. Cir. 1984), cert. denied, 469 U.S. 830, 225 USPQ 232 (1984); In re Dailey, 357 F.2d 669, 149 USPQ 47 (CCPA 1966).

3. Claim 3 is rejected under 35 U.S.C. 103(a) as being unpatentable over Calvert et al. (U.S. 6,348,240 B1) in view of the prior art as applied to claims 1, 2, 4-7, 9-17 and 22 above, and further in view of Schnur et al. (U.S. 5,079,600).

The combined teachings of Calvert et al. and the prior art teach that the second insulating layer is an oxide but fail to teach that said oxide is a silicon oxide. However, Schnur et al. (Figs.1-5) teach a selective deposition process including selectively depositing a metal over a functional layer, wherein the functional layer includes silicon oxide (column 8, lines 27 - 41). It would have been within the scope of one of ordinary skill in the art to combine the teachings of Calvert et al. and the prior art with the teachings of Schnur et al. to enable the use of silicon oxide as the second insulation layer in Calvert et al. and the prior art to be performed according to the teachings of Schnur et al. because one of ordinary skill in the art would have been motivated to look

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to alternative suitable methods of forming the second insulation layer of Calvert et al. and the prior art, and art recognized suitability for an intended purpose has been recognized to be motivation to combine. MPEP 2144.07.

4. Claim 8 is rejected under 35 U.S.C. 103(a) as being unpatentable over Calvert et al. (U.S. 6,348,240 B1) in view of the prior art and Nagura (U.S. 5,841,856).

Calvert et al. (Fig.1) in a related method to selectively deposit a conductive layer teach providing a substrate (column 7, lines 17 - 20); forming a first insulation layer on a substrate, wherein said layer is a diamond layer (column 7, lines 17 - 20); forming a second insulation layer on the first insulation layer, the second insulation layer having predetermined functional groups comprising OH functional groups (column 5, lines 15 - 34); etching the second insulation layer in accordance with the patterns of a patterned mask to create a patterned insulation layer (column 6, lines 5 - 22); treating the patterned insulation layer with a silane coupling agent reacting with the predetermined functional groups (column 5, lines 42 - 65); treating the patterned insulation layer with a catalyst-containing solution, wherein said catalyst containing solution includes palladium dichloride (column 6, lines 23 - 34); and depositing electrically conductive material on the patterned insulation layer (column 5, line 15 - 100), wherein the electrically conductive material comprises gold (Au) (column 2, lines 16 - 19).

Calvert et al. fail to teach forming a patterned polymer layer by photolithography having patterns on the second insulation layer; and striping the patterned polymer layer to expose the patterned insulation layer. However, the admitted prior art (Figs.1a-h) teaches the steps of providing a substrate (103); forming an insulation layer (101) on

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the substrate (103); forming a patterned polymer layer (109) by photolithography having the patterns on the insulation layer (101); etching the insulation layer (101) in accordance with the patterns of the patterned polymer layer (109) to create a patterned insulation layer; and stripping the patterned polymer layer (109) to expose the patterned insulation layer (page 1, line 10 – page 3, line 8). Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to use the patterned polymer layer as taught in the prior art to pattern the second insulation layer in the selective deposition process of Calvert et al., since this process involves conventional processes in the formation of patterns using photolithography (page 1, lines 16 - 17).

The combined teachings of Calvert et al. and the prior art fail to teach wherein the patterned polymer layer comprises a polyimide. However, Nagura (Figs.1B-1F) in a related patterning process teaches forming a patterned polymer layer (4a) over a silicon oxide layer (3), wherein said polymer layer comprises a polyimide (column 4, line 59 – 61). Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to use the polyimide layer as taught by Nagura to etch the second insulating layer of Calvert et al. and the prior art, since this would provide appropriate etching of the exposed areas of the insulating layer (column 4, lines 56 – 67).

## Response to Arguments

5. Applicant's arguments filed 09/08/2003 have been fully considered but they are not persuasive.

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Applicants argue, "... Calvert discloses that the diamond substrate, or diamond layer, is oxidized and functional groups are attached to the diamond surface, a mask is then formed and patterned on the diamond surface to modify the surface after the functional groups have been attached, and the remaining functional diamond surface is catalyzed to facilitate metallizing the surface. In other words, Calvert's diamond surface is a functional layer, and not a non-functional layer. Thus, Calvert does not disclose or suggest forming a non-functional layer on the substrate, much less forming a functional insulating layer having predetermined functional groups on the non-functional insulating layer. Since Calvert does not disclose or suggest the claim limitations as contended by the Examiner, Applicants respectfully submit that Calvert does not disclose or suggest a method for forming an electrically conductive layer having patterns for semiconductor devices, inter alia, comprising the steps of forming a non-functional insulation layer on the substrate...forming a functional insulation layer on the non-functional insulation layer, the functional insulation layer having predetermined functional groups, as essentially claimed in claims 1, 15, and 22...". In response to this argument, Calvert et al. teach oxidizing the surface of a diamond layer, not oxidizing the diamond layer (Calvert et al., column 5, lines 16 – 34), wherein after the oxidation step a first insulating layer comprising diamond and a second insulating layer comprising oxidized diamond would be obtained.

### Conclusion

6. **THIS ACTION IS MADE FINAL.** Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

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A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

7. Papers related to this application may be submitted directly to Art Unit 2823 by facsimile transmission. Papers should be faxed to Art Unit 2823 via the Art Unit 2823 Fax Center located in Crystal Plaza 4, room 3C23. The faxing of such papers must conform to the notice published in the Official Gazette, 1096 OG 30 (15 November 1989). The Art Unit 2823 Fax Center number is (703) 305-3432. The Art Unit 2823 Fax Center is to be used only for papers related to Art Unit 2823 applications.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to **Julio J. Maldonado** at **(703) 306-0098** and between the hours of 8:00 AM to 4:00 PM (Eastern Standard Time) Monday through Friday or by e-mail via <u>julio.maldonado@uspto.gov</u>. If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Olik Chaudhuri, can be reached on (703) 306-2794.

Any inquiry of a general nature or relating to the status of this application should be directed to the **Group 2800 Receptionist** at **(703) 308-0956**.

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